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Docket No. 030712-22

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re New Patent Application of)
Seiji ANDOH)
Japanese Priority Application No. 2003-372783) Attn: Applications
Japanese Priority Date: October 31, 2003) Branch
For: SEMICONDUCTOR DEVICE) Date: January 30, 2003

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure as set forth in 37 C.F.R. §1.56, Applicants hereby submit the following information in conformance with 37 C.F.R. §§ 1.97 and 1.98. Pursuant to 37 C.F.R. § 1.98, a copy of each of the documents cited is enclosed.

It is requested that the accompanying PTO-1449 be considered and made of record in the above-identified application. To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner initialed copy of this form be returned to the undersigned.

Respectfully submitted,

By: D 214 D 64

Donald R. Studebaker Registration No. 32,815

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Telephone: (202) 585-8000

Substitute for form 1449A/PTO INFORMATION DISCLOSURE				Complete if Known		
			AGUDE	Application Number	New Application	
	··			Filing Date	January 30, 2004	
STATEMENT BY APPLICANT (use as many sheets as necessary)		First Named Inventor	Seiji ANDOH			
		Art Unit				
		Examiner				
Sheet	1	of	1	Attorney Docket Number	030712-22	

	U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.'	U.S. Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		Number - Kind Code ² (if known)		Applicant of Cited Document			
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		F	FOREIGN PATENT	DOCUMENTS	<u> </u>	
Examiner Initials*	Cite No. 1	Foreign Patent Document Kind Code ⁵ Country Code ³ Number ⁴ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		JP 11-163201	08/16/1999	Yaguchi et al.		Full
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		OTHER PRIOR	R ART - NON PATENT	LITERATURE DOCUMENTS		
Examiner Initials	Cite No.1		or (in CAPITAL LETTERS), title of the article (when appropriate), title of the mal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published.			
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Examiner	Date	
Signature	Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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